Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/708,822	BEENAU ET AL.
Examiner	Art Unit
Daniel I. Walsh	2876

SEARCHED				
Class	Subclass	Date	Examiner	
	;			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	ly 11			

SEARCH (INCLUDING SEAR		')
	DATE	EXMR
EAST Search attached	4/9/2007	DW
•		
-		